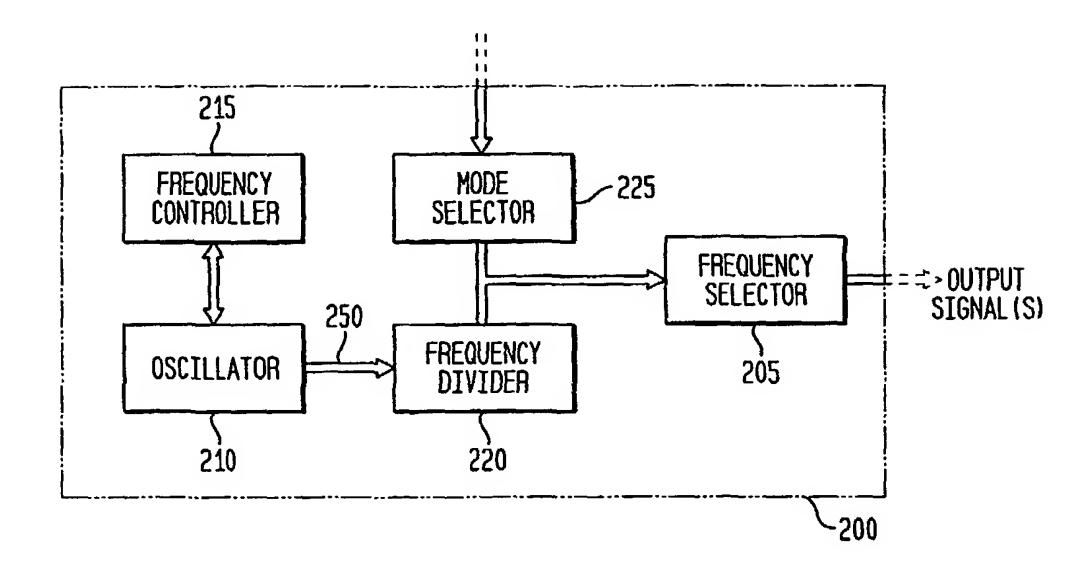
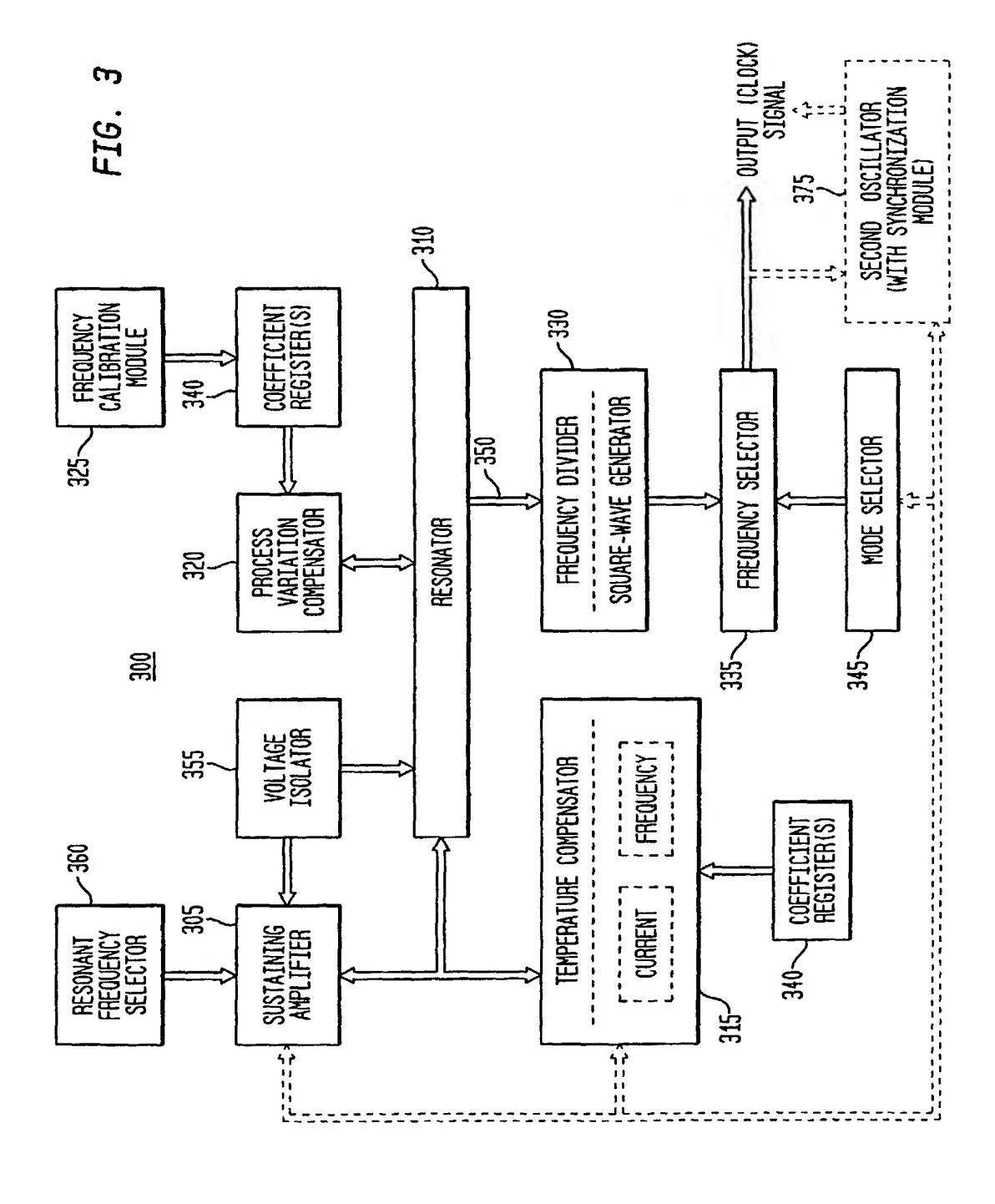


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FIG. 2





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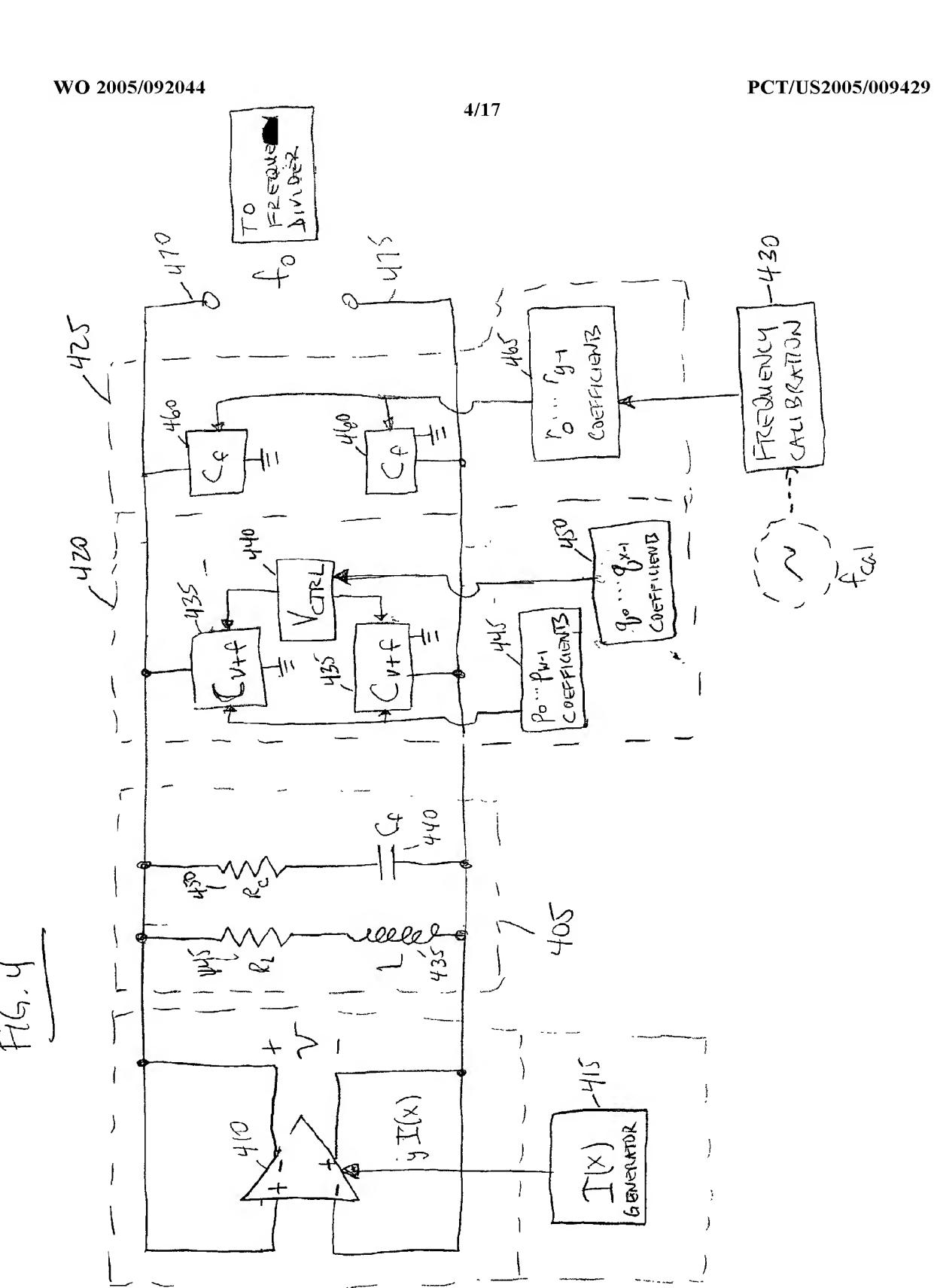


FIG. 5A

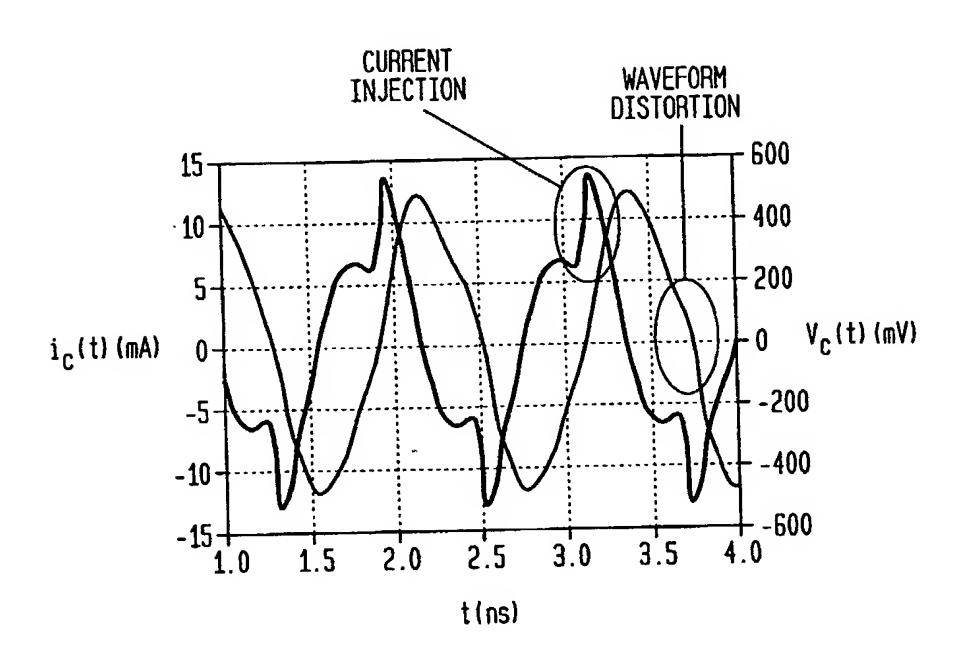
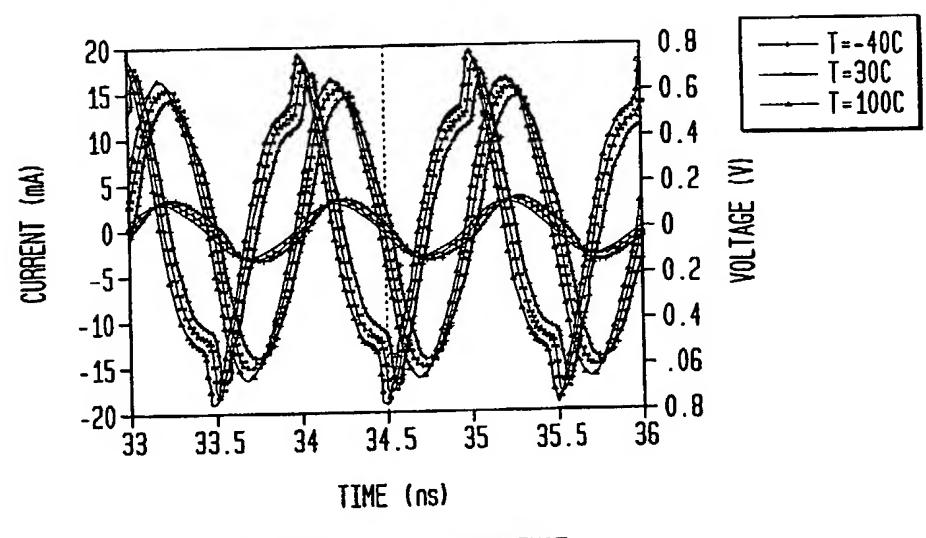
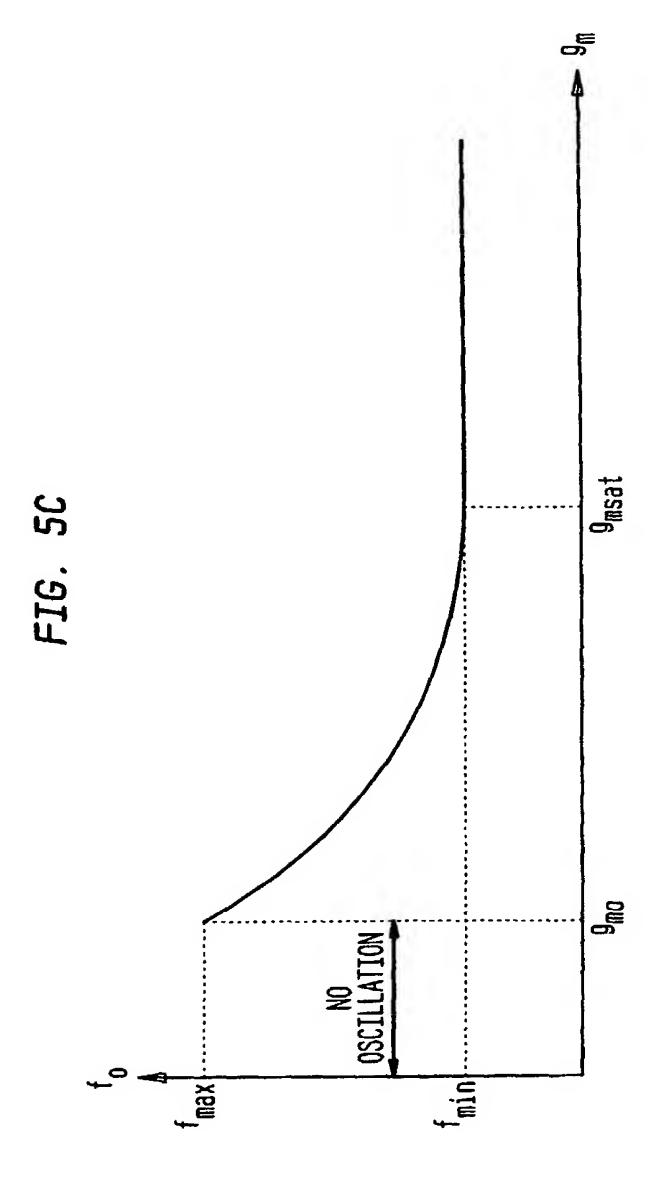


FIG. 5B



TEMPERATURE/BIAS DEPENDENCE



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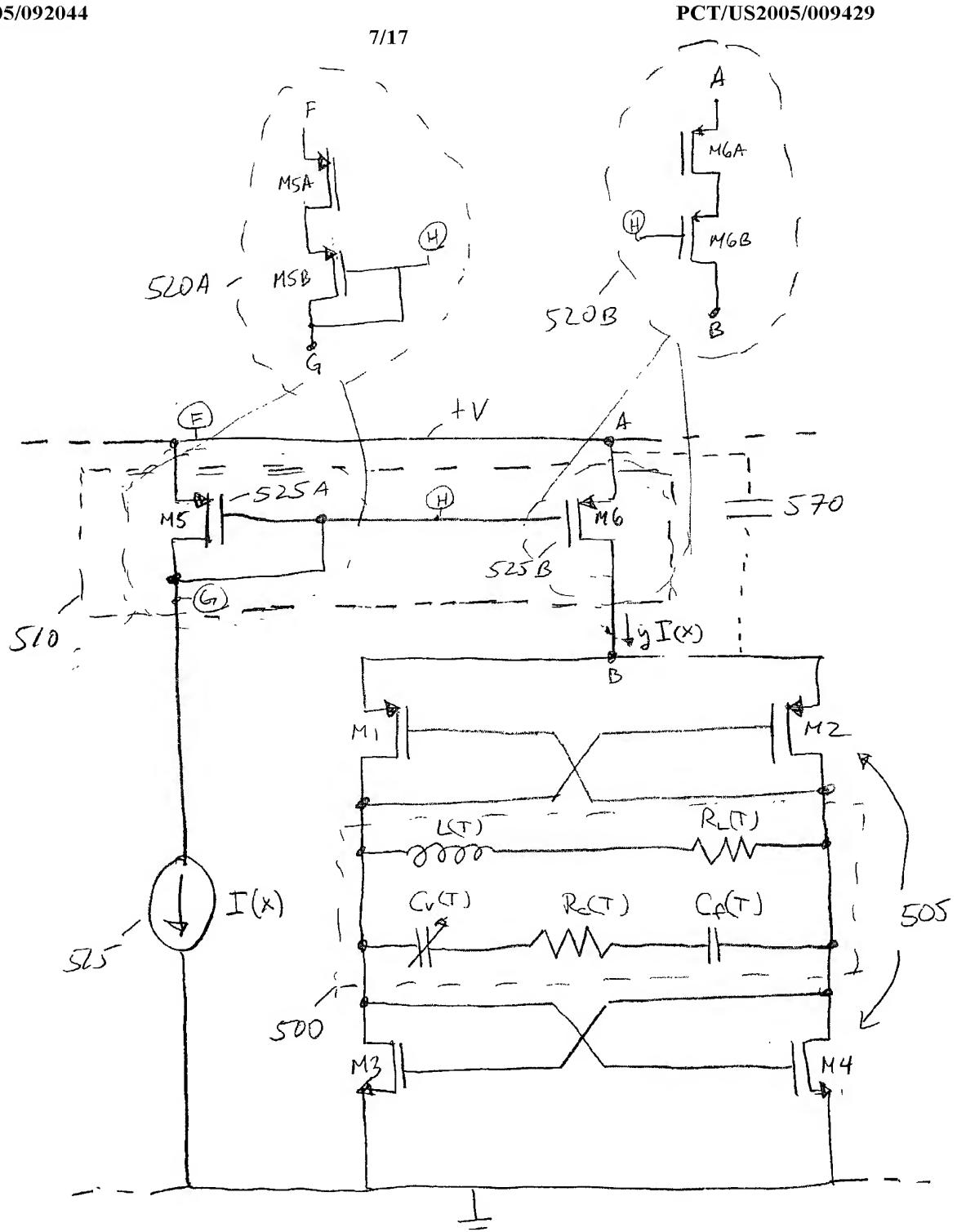


FIGURE 6

FIG. 7A

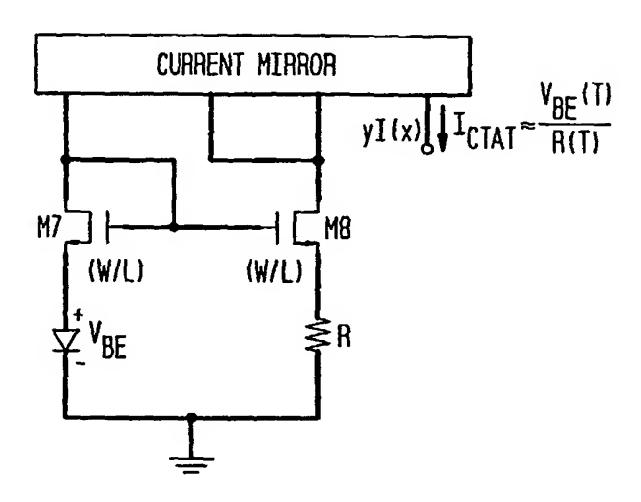


FIG. 7B

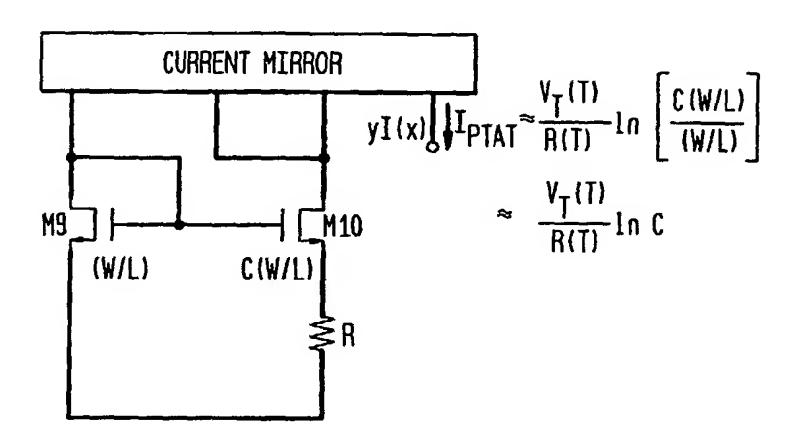


FIG. 7C

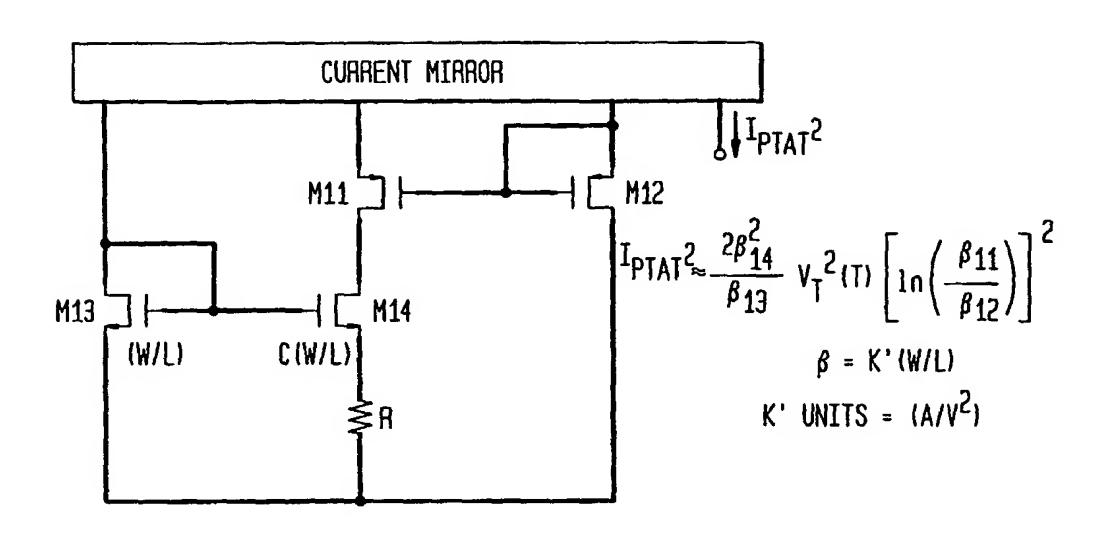
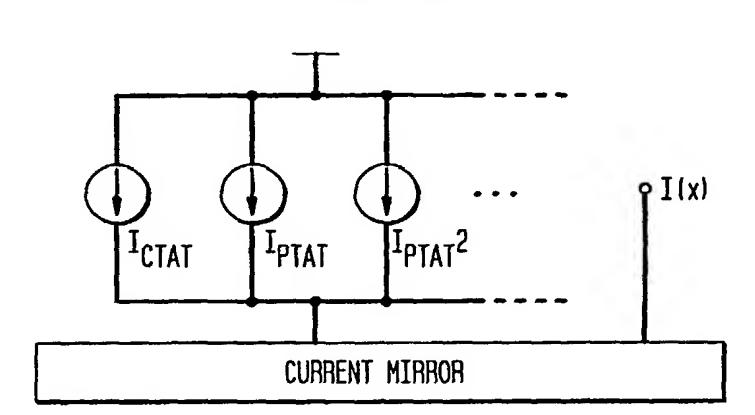


FIG. 7D



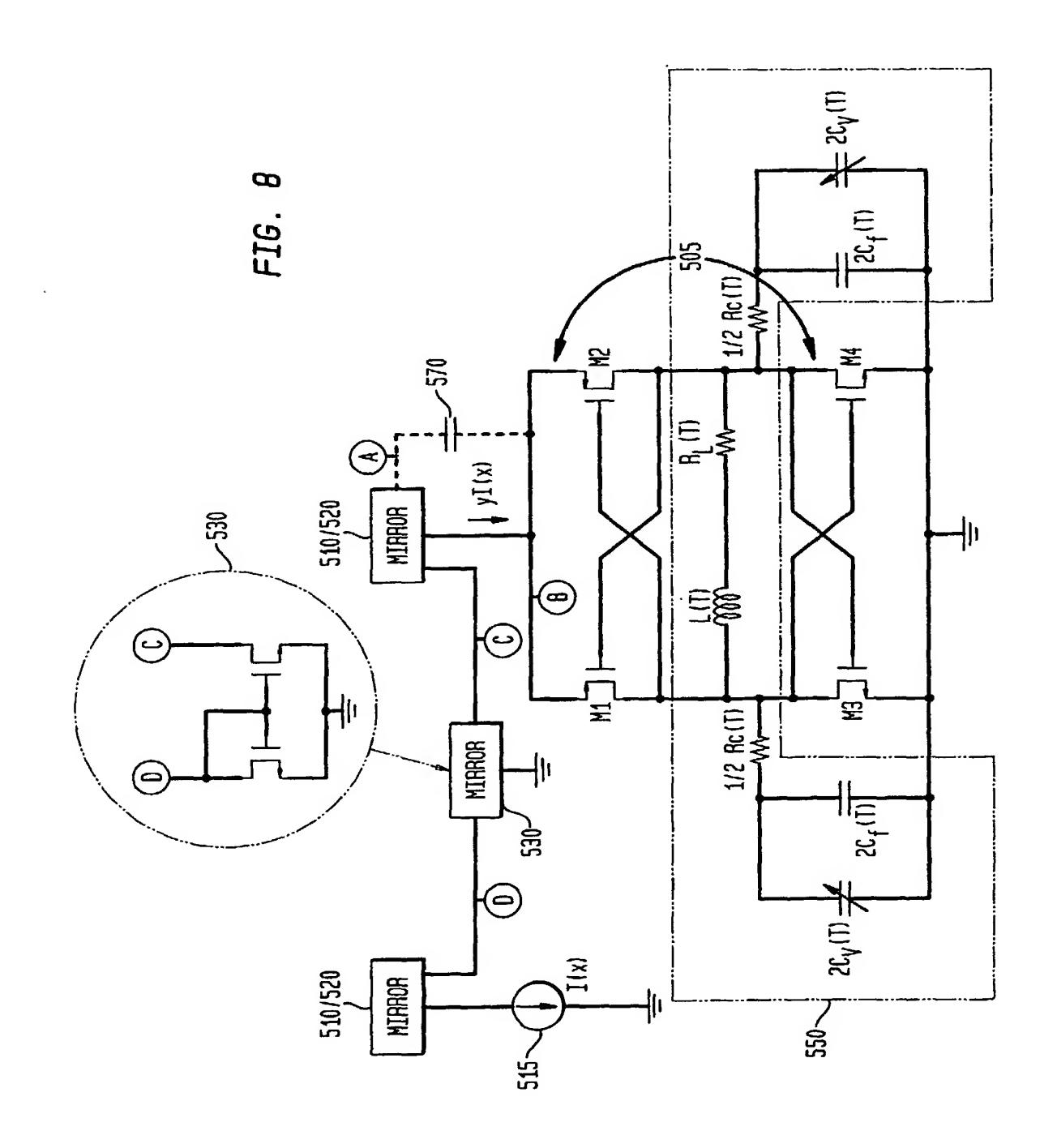


FIG. 9

10 NODES 470/475

2x-1c_v
615(w-1)

Vctr1 (T)

625

1c_v
615₀
620₀
635

FIG. 10

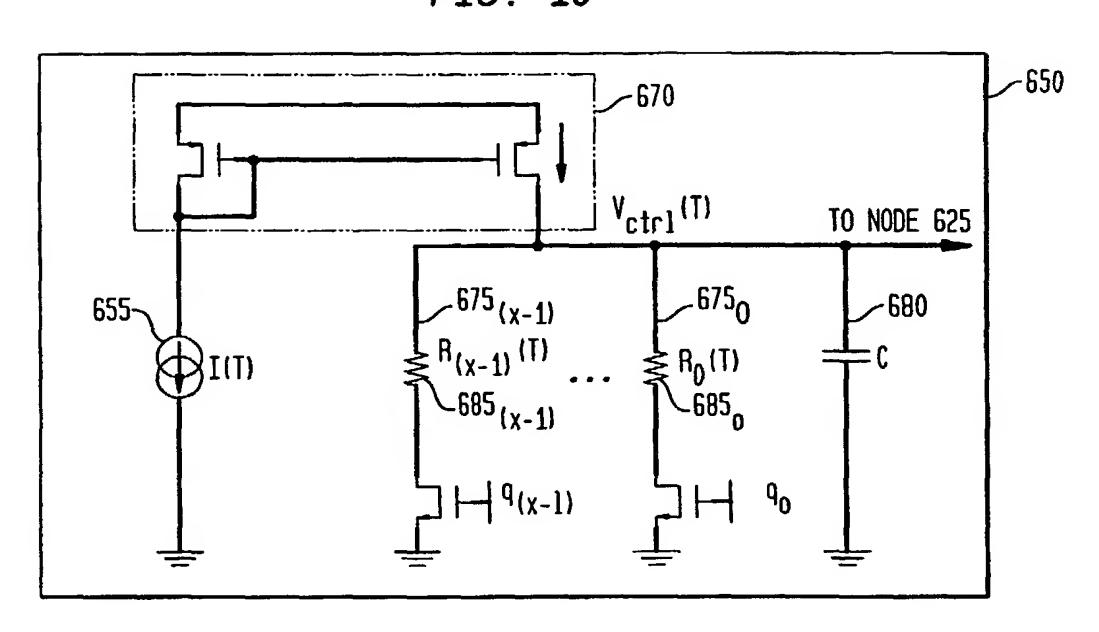
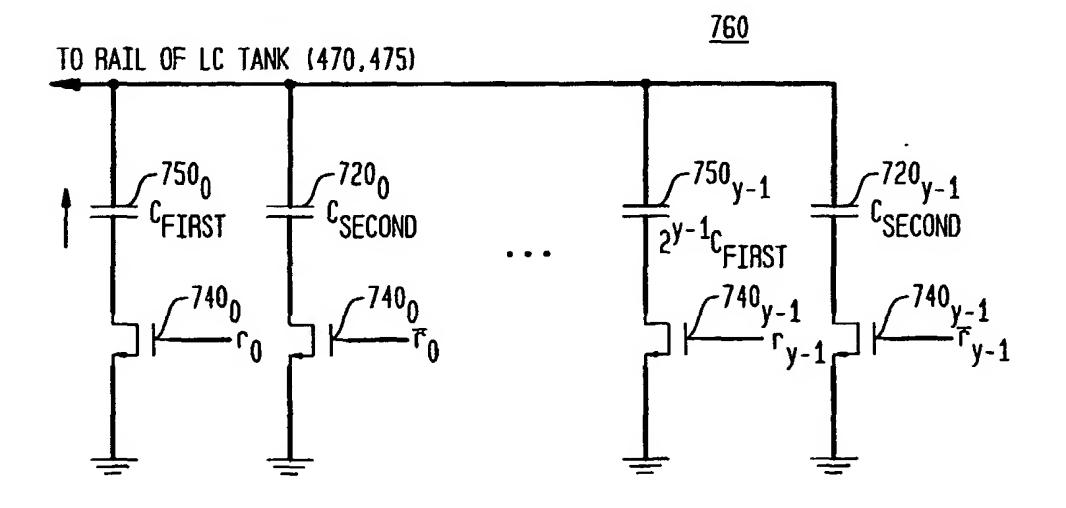
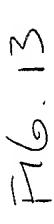
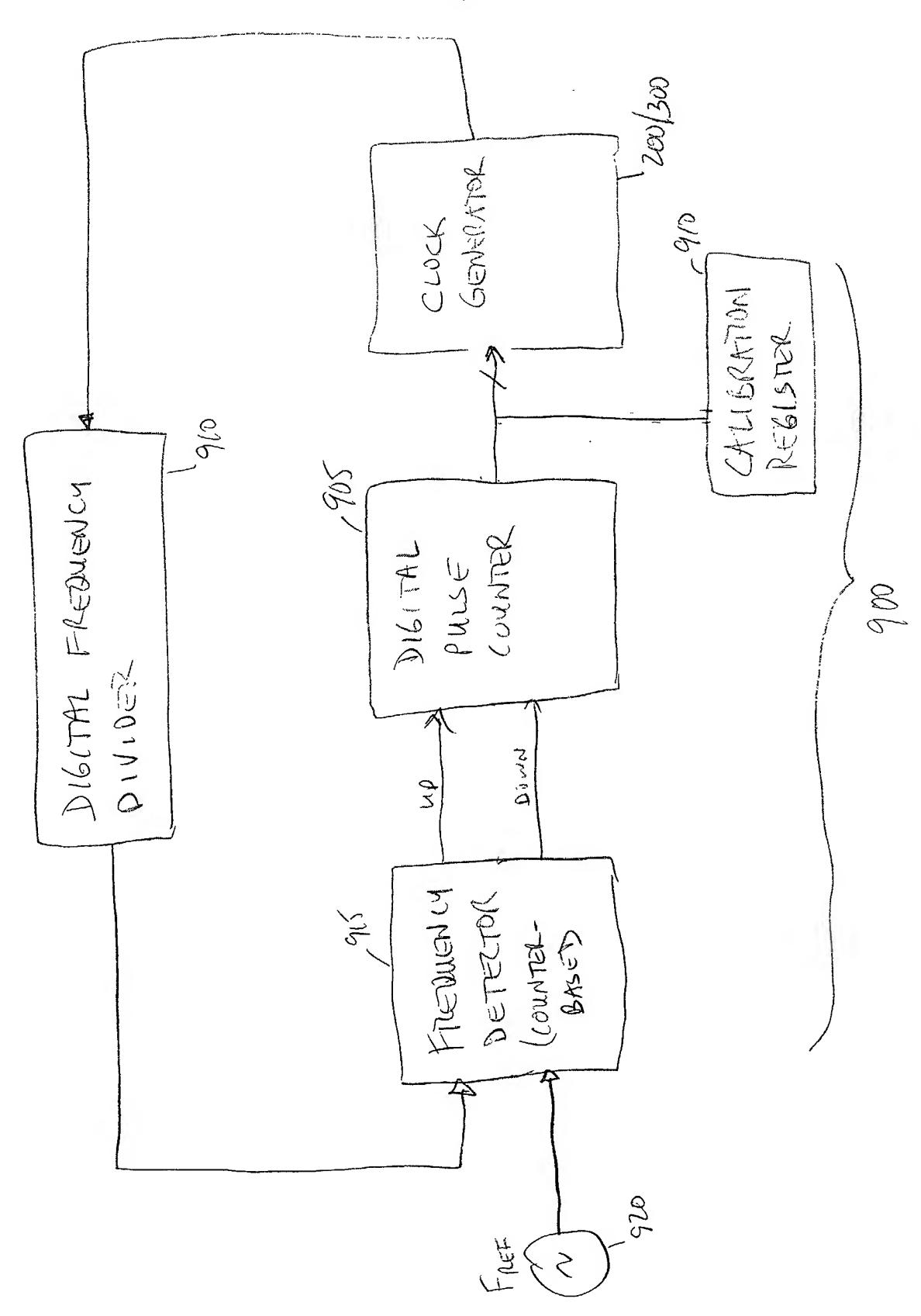


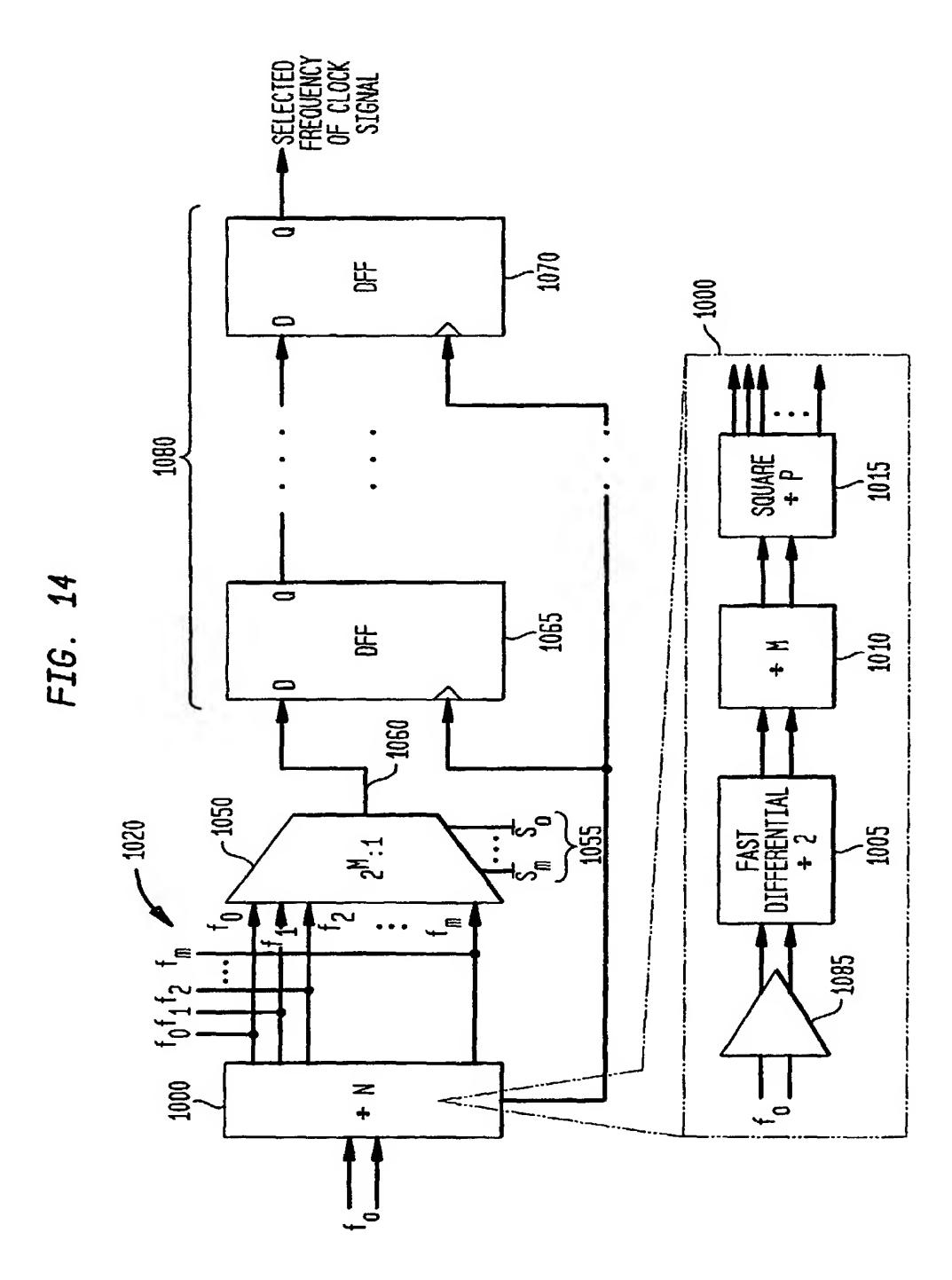
FIG. 11



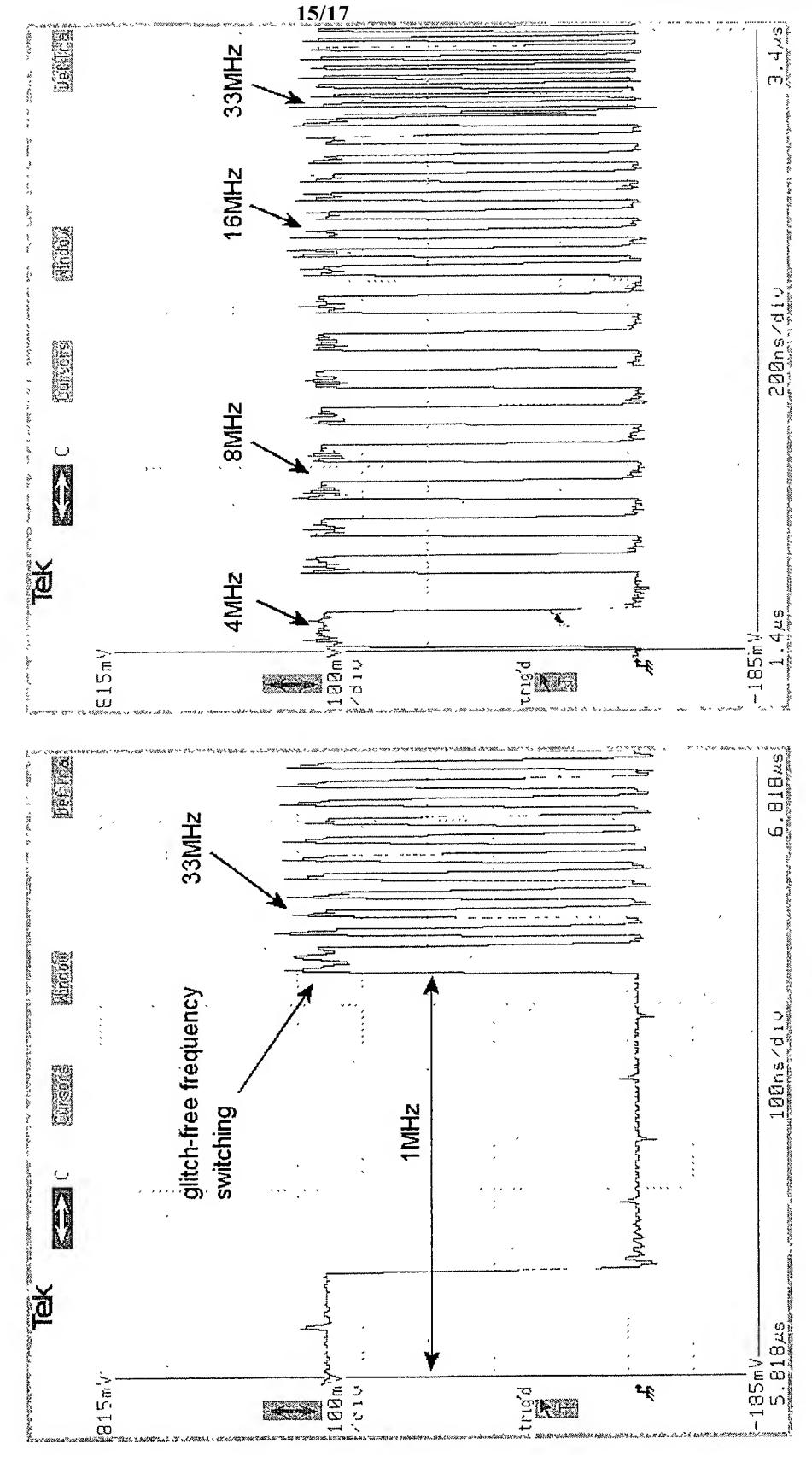
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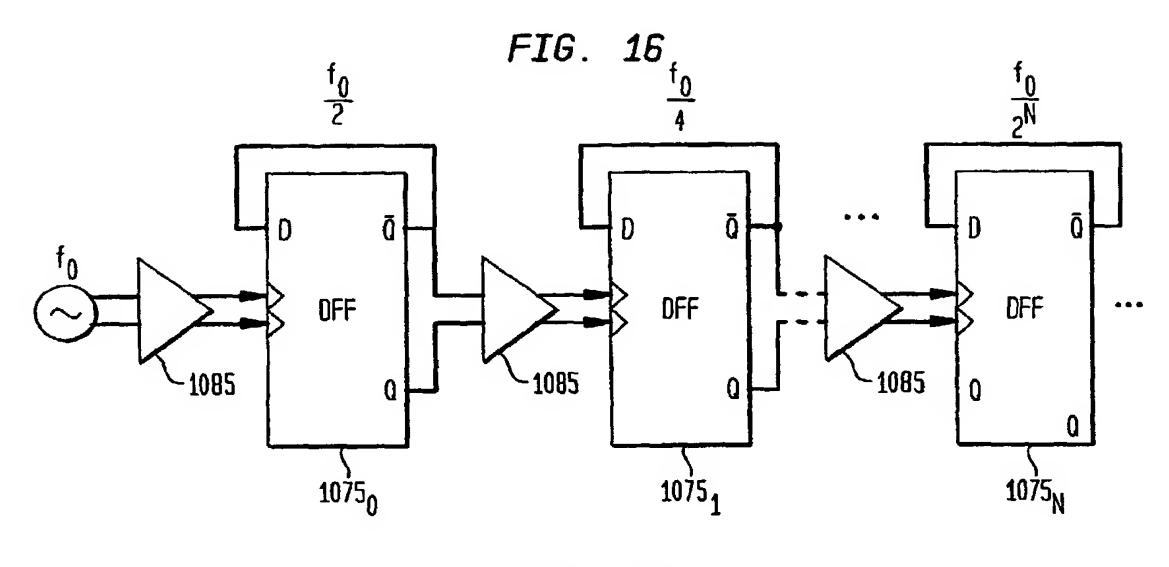


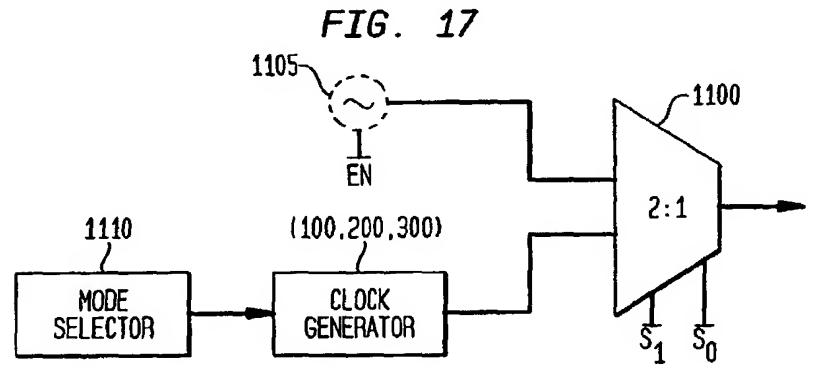
Measured frequency switching for a 16-bit MS-MCL

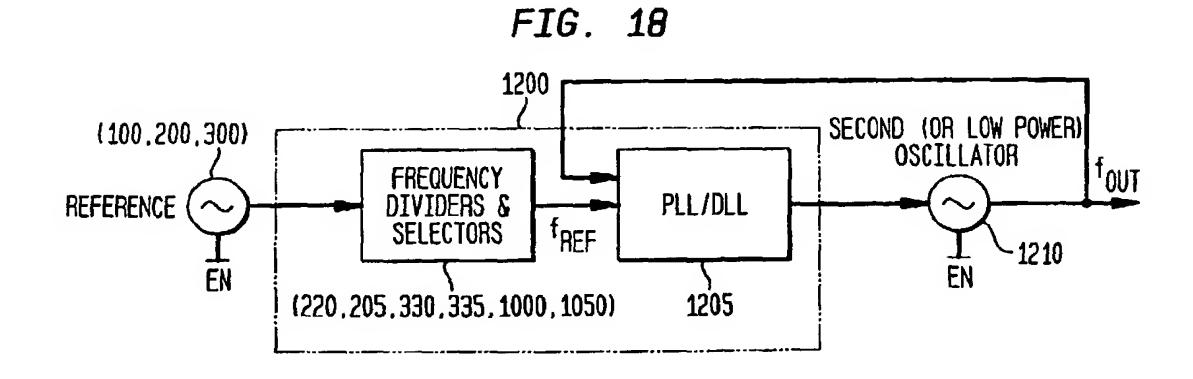


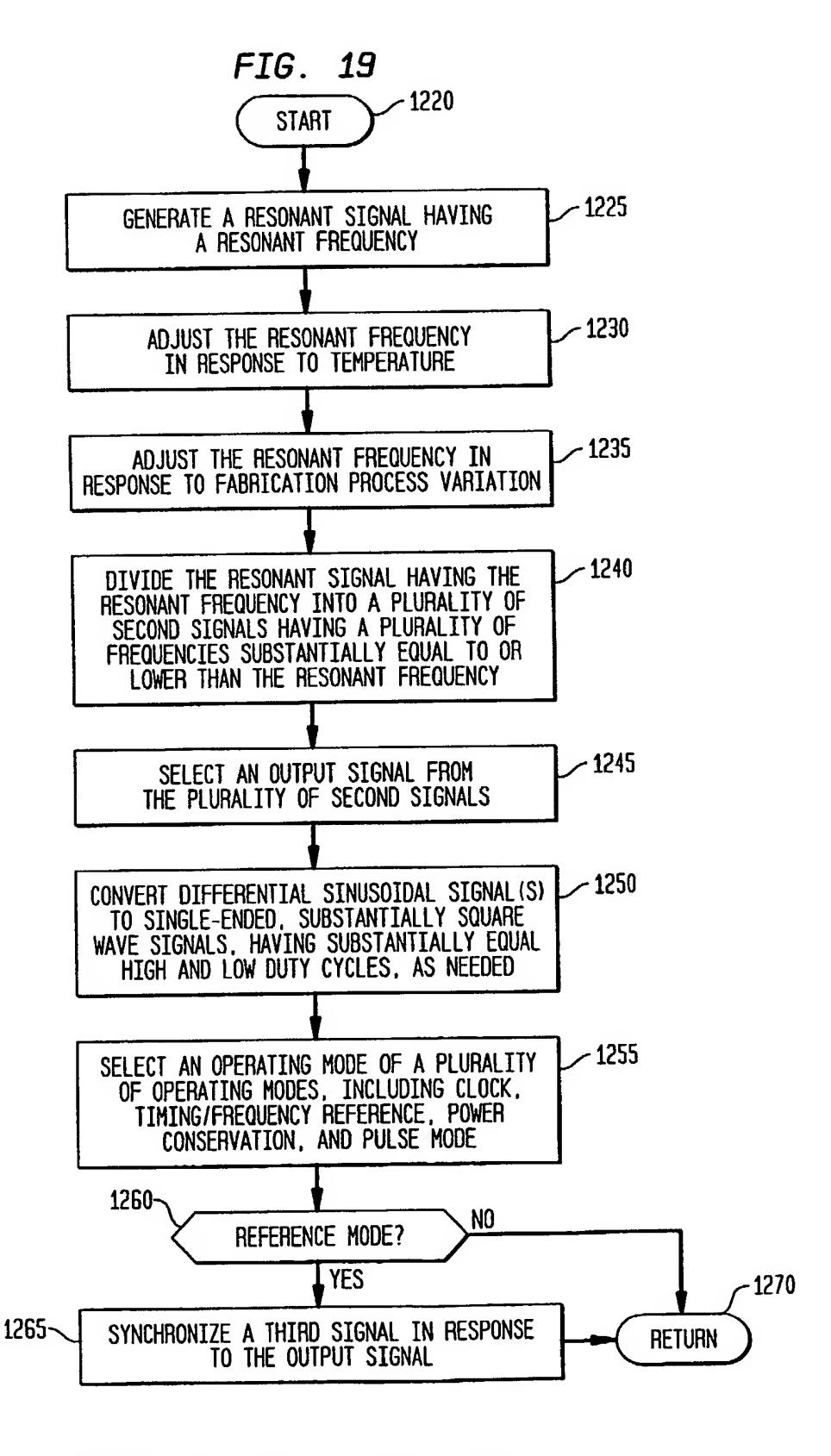
1 GURE 15 A

M









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